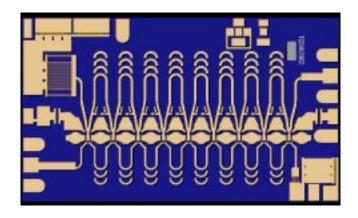


# **Advance Product Information July 22, 2004**

## 12.5Gb/s Modulator Driver Amplifier

## **TGA4802-EPU**

**Metro and Long Haul Applications** 



# Description

The TriQuint TGA4802 is part of a series of optical driver amplifiers suitable for a variety of driver applications.

The TGA4802 is a medium power wideband AGC amplifier MMIC die that typically provides 15dB small signal gain with 10dB AGC range. RF ports are DC coupled enabling the user to customize system corner frequencies.

The TGA4802 is an excellent choice for 12.5Gb/s optical modulator driver applications. The TGA4802 has demonstrated capability to amplify a 2V input signal to 7Vpp saturated.

The TGA4802 requires off-chip decoupling, a DC block and a bias tee. The TGA4802 is available in die form.

## **Key Features and Performance**

- Frequency Range: DC 25 GHz
- Single-ended Input / Output
- 15 dB Small Signal Gain
- 18 GHz Small Signal Bandwidth
- Wide Drive Range (3V to 7V)
- 15ps Edge Rates (20/80)
- Power Dissipation 1.2 Watts
- 0.25um pHEMT 2MI Technology
- Die Size: 3.3 x 2.0 x 0.1 mm (0.131 x 0.79 x 0.004 inches)

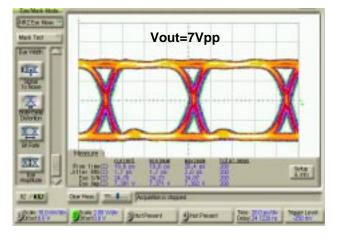
## **Primary Applications**

 Mach-Zehnder Modulator Driver for Metro and Long Haul

#### **Measured Performance**

TGA4802 Fixtured Data Vd(Rfout)=6V, Id=170mA, (Pdc=1.2W) Vout=7Vpp, Vin = 2Vpp Scale: 2V/div, 20ps/div

12.5Gb/s Vin=2V





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# TABLE I MAXIMUM RATINGS 1/

SYMBOL	PARAMETER	VALUE	NOTES
	POSITIVE SUPPLY VOLTAGE		
Vd	Drain Voltage at RF output	7 V	<u>2</u> /
	POSITIVE SUPPLY CURRENT		
ld	Drain Current	200 mA	<u>2</u> /
$P_{d}$	POWER DISSIPATION	1.4 W	<u>2</u> /, 3/
	NEGATIVE GATE		
Vg	Voltage	0 V to −3 V	
lg	Gate Current	5 mA	
	CONTROL GATE		
Vctrl	Voltage	Vd/2 to −3 V	4/
lctrl	Gate Current	5 mA	
	RF INPUT		
P <sub>IN</sub>	Sinusoidal Continuous Wave Power	23 dBm	
T <sub>CH</sub>	OPERATING CHANNEL TEMPERATURE	150 °C	5/, 6/
T <sub>M</sub>	MOUNTING TEMPERATURE	320 °C	
	(30 SECONDS)		
T <sub>STG</sub>	STORAGE TEMPERATURE	-65 to 150 °C	

#### Notes:

- 1/ These ratings represent the maximum operable values for the device.
- 2/ Assure the combination of Vd and Id does not exceed maximum power dissipation rating.
- 3/ Assure Vctrl never exceeds Vd during bias on and off sequences, and normal operation.
- 4/ When operated at this bias condition with a base plate temperature of 70°C, the median life is reduced.
- 5/ Junction operating temperature will directly affect the device median time to failure (MTTF). For maximum life, it is recommended that junction temperatures be maintained at the lowest possible levels.
- 6/ These ratings apply to each individual FET.

### TABLE II DC PROBE TEST

 $(TA = 25 \, ^{\circ}C, nominal)$ 

NOTES	SYMBOL	LIMI	UNITS	
		MIN	MAX	
1/	V <sub>BVGS</sub>	11	30	V
<u>1</u> /	$ V_{BVGD} $	11	30	V

#### Notes:

<sup>1</sup>  $V_{BVGS}$  and  $V_{BVDS}$  are negative.



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# TABLE III RF SPECIFICATIONS

 $(T_A = 25^{\circ}C \text{ Nominal})$ 

Bias Conditions: Vd = 7V Id = 170 mA

NOTE	TEST	MEASUREMENT CONDITIONS	VALUE		UNITS	
			MIN	TYP	MAX	
	SMALL SIGNAL BW			18		GHz
<u>1/</u>	SMALL-SIGNAL	2 - 10 GHz	14			dB
	GAIN MAGNITUDE	12 - 18 GHz	10			
<u>1</u> /	INPUT RETURN LOSS MAGNITUDE	2 - 14 GHz		10		dB
<u>1</u> /	OUTPUT RETURN LOSS MAGNITUDE	2 - 14 GHz		12		dB
<u>2/</u> <u>3/</u>	SATURATED OUTPUT POWER	2 - 12 GHz	22			dBm
<u>2/, 3/</u>	EYE AMPLITUDE	Vd(RFout) = 6V	7.0			Vpp
		Vd(RFout) = 5V	6.0			
		Vd(RFout) = 4V	5.0			
2/, 4/	ADDITIVE JITTER			5		ps
<u>2/, 4/</u>	RISE TIME (20/80)			15		ps

#### Notes:

- 1/ RF Probe Bias: V+ = 8 V, adjust Vg1 to achieve Id = 80 mA, Vctrl = +1.5 V
- 2/ Verified by design, TGA4802 assembled onto an evaluation platform as shown on page 9 then tested using the application circuit and bias procedure detailed on pages 7 and 8.
- 3/ Vin = 2 V, Data Rate = 12.5 Gb/s, Vctrl and Vg are adjusted for maximum output.
- 4/ Computed using RSS Method where Jpp\_additive = SQRT(Jpp\_out<sup>2</sup> Jpp\_in<sup>2</sup>)



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## TABLE IV THERMAL INFORMATION\*

PARAMETER	TEST CONDITIONS	T <sub>CH</sub> (°C)	R <sub>θJC</sub> (°C/W)	T <sub>M</sub> (HRS)
R <sub>eJC</sub> Thermal Resistance (channel to backside of carrier)	Vd (RF out) = 7 V $I_D = 170 mA$ Pdiss = 1.2 W	110	32.7	4.2 E+7

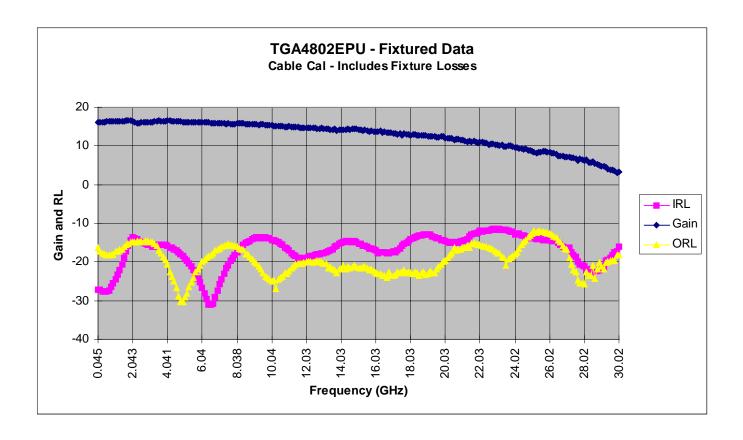
Note: Assumes eutectic attach using 1.5 mil 80/20 AuSn mounted to a 20 mil CuMo Carrier at 70°C baseplate temperature. Worst case condition with no RF applied, 100% of DC power is dissipated. Thermal transfer is conducted thru the bottom of the TGA4802 into the mounting carrier. Design the mounting interface to assure adequate thermal transfer to the base plate.



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## **Measured Fixtured Data**

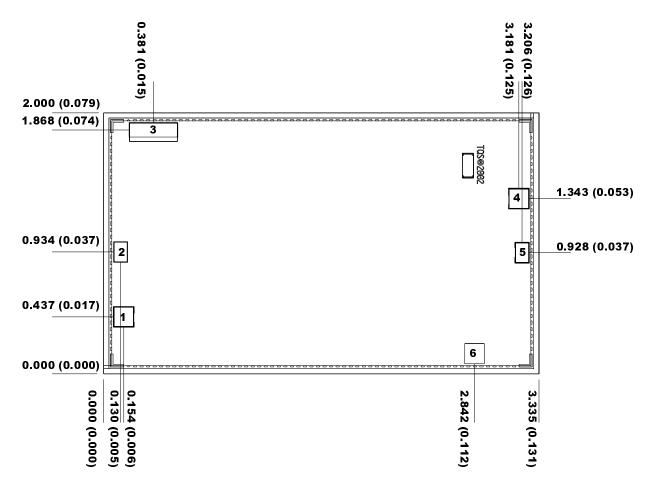
Bias Conditions: Vd = 7V, Id= 170mA





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## **Mechanical Drawing**



Units: millimeters (inches) Thickness: 0.100 (0.004)

Chip edge to bond pad dimensions are shown to center of bond pad

Chip size tolerance: +/- 0.051 (0.002)

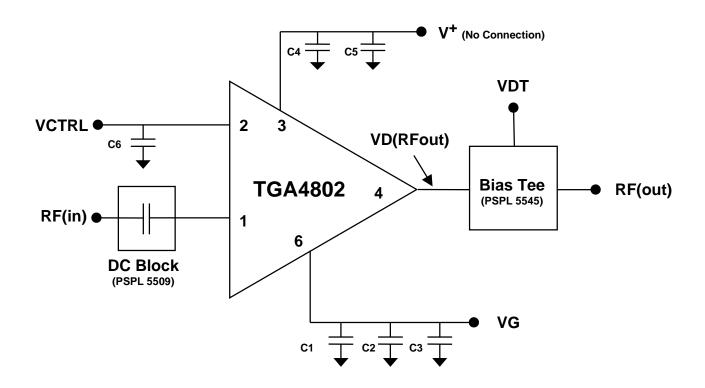
Bond pad #1	(RF In)	0.150 x 0.150 (0.006 x 0.006)
Bond pad #2	(Vctrl)	$0.100 \times 0.150 (0.004 \times 0.006)$
Bond pad #3	(V+)	0.366 x 0.108 (0.014 x 0.004)
Bond pad #4	(RF Out)	$0.155 \times 0.155 (0.006 \times 0.006)$
Bond pad #5	(Vctrl aux)	$0.100 \times 0.150 (0.004 \times 0.006)$
Bond pad #6	(Vg)	$0.150 \times 0.150 (0.006 \times 0.006)$

GaAs MMIC devices are susceptible to damage from Electrostatic Discharge. Proper precautions should be observed during handling, assembly and test.



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## **TGA4802 Application Circuit**



#### Notes:

Recommended Components are detailed on page 9.



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## **Bias Procedure for 7V Output**

#### **Bias ON**

- 1. Disable the RF source (PPG)
- 2. Set VdT=0V Vctrl=0V and Vg=0V
- 3. Set Vg=-1.5V
- 4. Increase VdT to 7V observing Id.
  - Assure Id=0mA
- 5. Set Vctrl=+1.0V
  - Id should still be 0mA
- 6. Make Vg more positive until Idd=170mA.
  - Typical value for Vg is -0.2V
- 7. Measure V<sup>+</sup>, adjust VdT such that V<sup>+</sup> is 6V.
  - This will set Vd(RFout) to approximately 6V.
  - Idd will increase slightly
- 8. Adjust Vg such that Idd=170mA.
- 9. Enable the RF source (PPG)
  - Set Vin=2V
- 10. <u>Output Swing Adjust:</u> Adjust <u>Vctrl</u> slightly positive to increase output swing or adjust Vctrl slightly negative to decrease the output swing.
  - Typical value for Vctrl is +1.0V for Vo=7V.
- 11. <u>Crossover Adjust: Adjust:</u> Vg slightly positive to push the crossover down or adjust Vg slightly negative to push the crossover up.
  - Typical value for <u>Vg is -0.2V</u> to center crossover with Vo=7V.

#### Notes:

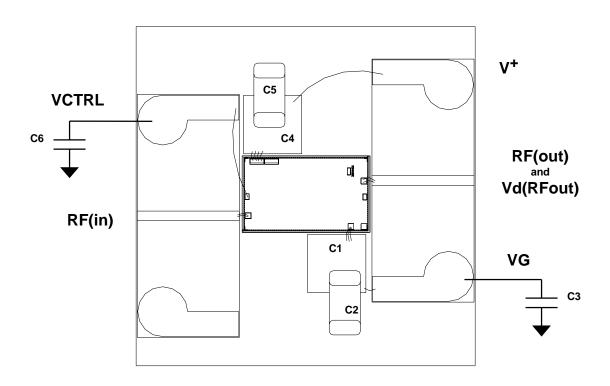
1. Assure Vctrl never exceeds Vd during Bias ON and Bias OFF sequences and during normal operation.

#### **Bias OFF**

- 1. Disable the output of the PPG
- 2. Set Vctrl=0V
- 3. Set VdT=0V
- 4. Set Vg=0V



## **Evaluation Platform Assembly Diagram**



## **Recommended Components:**

DESIGNATOR	DESCRIPTION	MANUFACTURER	PART NUMBER
C1, C4	1500pF Capacitor SLC	Presidio	SL5050X7R1522H5
C2, C5	0.1uF Capacitor MLC Ceramic	AVX	0603YC104KAT
C3	10uF Capacitor MLC Ceramic	AVX	0603YC102KAT
C6	0.01 uF Capacitor MLC	AVX	0603YC103KAT

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## **Evaluation Platform Assembly Notes**

#### Assembly Notes:

#### Reflow Attachment:

Use AuSn (80/20) solder with limited exposure to temperatures at or above 300 C Use alloy station or conveyor furnace with reducing atmosphere No fluxes should be utilized Coefficient of thermal expansion matching is critical for long-term reliability Storage in dry nitrogen atmosphere

#### Adhesive Attachment:

Organic attachment can be used in low-power applications
Curing should be done in a convection oven; proper exhaust is a safety concern
Microwave or radiant curing should not be used because of differential heating
Coefficient of thermal expansion matching is critical

#### Component Pickup and Placement:

Vacuum pencil and/or vacuum collet preferred method of pick up Avoidance of air bridges during placement Force impact critical during auto placement

#### Interconnect:

Thermosonic ball bonding is the preferred interconnect technique Force, time, and ultrasonics are critical parameters
Aluminum wire should not be used
Discrete FET devices with small pad sizes should be bonded with 0.0007-inch wire Maximum stage temperature: 200 • C